

FCC TEST REPORT FCC ID:2AL6KBL-M8852BS2 Report Number.....: ZKT-2310248076E-4 Date of Test..... Oct. 24, 2023 to Dec. 15, 2023 Date of issue..... Dec. 15, 2023 Total number of pages..... 22 Test Result: PASS Testing Laboratory.....: Shenzhen ZKT Technology Co., Ltd. Applicant's name: Shenzhen Bilian Electronic Co.,Ltd. Room 501, Building 3, No. 32, Dafu Road, Zhangge Community, Address: Fucheng Street, Longhua District, Shenzhen City Manufacturer's name Shenzhen Bilian Electronic Co.,Ltd. Room 501, Building 3, No. 32, Dafu Road, Zhangge Community, Address: Fucheng Street, Longhua District, Shenzhen City Test specification: FCC CFR Title 47 Part 15 Subpart E Section 15.407 Standard.....: ANSI C63.10:2013 KDB 789033 D02 v02r01 Test procedure.....: / Non-standard test method: N/A Test Report Form No.....: / Test Report Form(s) Originator.....: ZKT Testing Master TRF: Dated: 2020-01-06 This device described above has been tested by ZKT, and the test results show that the equipment under test (EUT) is in compliance with the FCC requirements. And it is applicable only to the tested sample identified in the report. This report shall not be reproduced except in full, without the written approval of ZKT, this document may be altered or revised by ZKT, personal only, and shall be noted in the revision of the document. 802.11a/b/g/n/ac/ax 1200Mbps WLAN + Bluetooth v5.2 Combo Product name.....: **SDIO Module** Trademark: N/A Model/Type reference..... BL-M8852BS2 Ratings.....: Input: 3.3V === 1A

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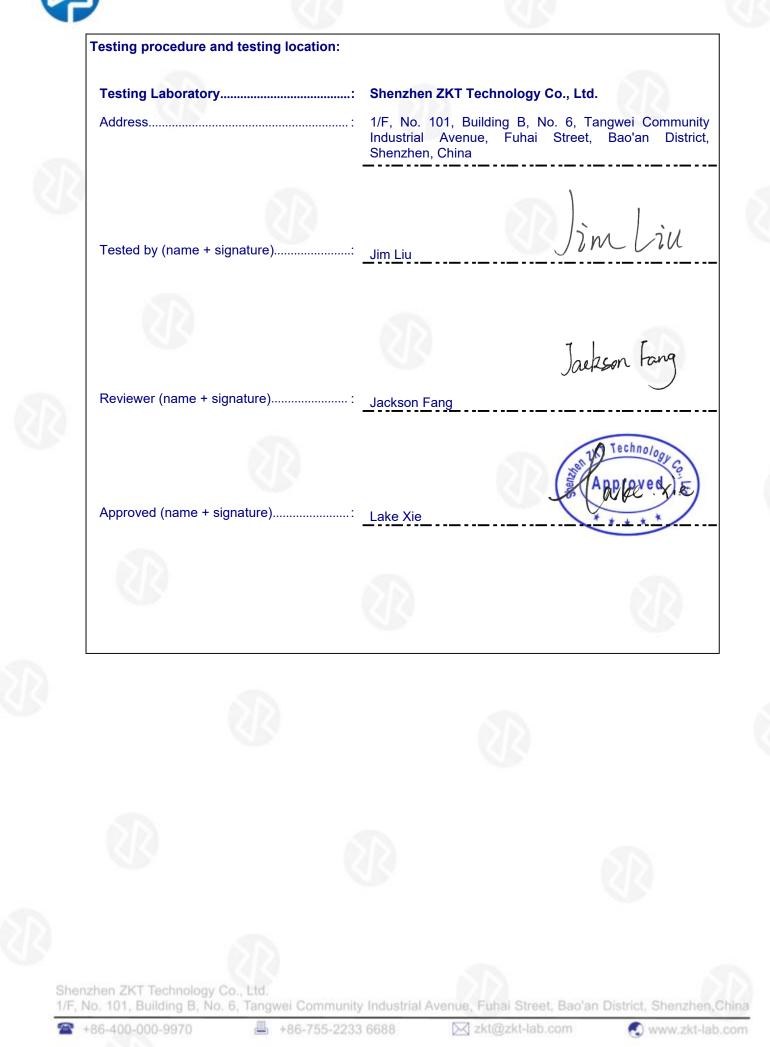




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(Note: N/A means not applicable)





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1. VERSION

Report No.	Issue Date	Description	Approved
ZKT-2310248076E-4	Dec. 15, 2023	Original	Valid
nzhen ZKT Technology Co., L	4		



2. TEST SUMMARY

The Product has been tested according to the following specifications:

Test Item	Test Requirement	Test method	Result
DFS Detection Threshold	47 CFR Part 15 Subpart E Section 15.407 (h)(2)	KDB 905462 D02	N/A
Channel Availability Check Time	47 CFR Part 15 Subpart E Section 15.407 (h)(2)(ii)	KDB 905462 D02	N/A
U-NII Detection Bandwidth	47 CFR Part 15 Subpart E Section 15.407 (h)(2)	KDB 905462 D02	N/A
Channel Closing Transmission Time	47 CFR Part 15 Subpart E Section 15.407 (h)(2)(iii)	KDB 905462 D02	PASS
Channel Move Time	47 CFR Part 15 Subpart E Section 15.407 (h)(2)(iii)	KDB 905462 D02	PASS
Non-Occupancy Period	47 CFR Part 15 Subpart E Section 15.407 (h)(2)(iv)	KDB 905462 D02	PASS

Remark:

The tested sample and the sample information are provided by the client.

Tx: In this whole report Tx (or tx) means Transmitter.

Rx: In this whole report Rx (or rx) means Receiver.

RF: In this whole report RF means Radiated Frequency.

- CH: In this whole report CH means channel.
- Volt: In this whole report Volt means Voltage.

Temp: In this whole report Temp means Temperature.

Humid: In this whole report Humid means humidity.

Press: In this whole report Press means Pressure.

N/A: In this whole report not application.

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3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

No.	Item	Uncertainty
1	Occupancy bandwidth	U=±54.3Hz
2	Adjacent channel power	U=±1.3dB
3	Conducted Adjacent channel power	U=±1.38dB
4	Conducted output power Above 1G	U=±1.0dB
5	Conducted output power below 1G	U=±0.9dB
6	Power Spectral Density , Conduction	U=±1.0dB
7	Conduction spurious emissions	U=±2.8dB
8	Out of band emission	U=±54Hz
9	3m camber Radiated spurious emission(30MHz-1GHz)	U=±4.3dB
10	3m chamber Radiated spurious emission(1GHz-18GHz)	U=±4.5dB
11	humidity uncertainty	U=±5.3%
12	Temperature uncertainty	U=±0.59 ℃
13	Supply volyages	U=±3%
14	Time	U=±5%





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4. PRODUCT INFORMATION AND TEST SETUP

4.1 Product Information

Model(s):	BL-M8852BS2
Model Description:	N/A
Wi-Fi Specification:	IEEE 802.11a/b/g/n/ac/ax
Hardware Version:	V1.0
Software Version:	V1.0
Operation Frequency:	IEEE 802.11a/n/ac(20M): 5150MHz ~5250MHz/ 4 channel IEEE 802.11n/ac(40M): 5150MHz ~5250MHz/ 2 channel IEEE 802.11ac/ax(80M): 5150MHz ~5250MHz/ 1 channel
	IEEE 802.11a/n/ac(20M): 5250MHz ~5350 MHz/ 4 channel IEEE802.11n/ac(40M): 5250MHz ~5350 MHz/ 2 channel IEEE802.11ac/ax(80M): 5250MHz ~5350 MHz/ 1 channel
	IEEE 802.11a/n/ac(20M): 5470MHz ~5725 MHz/ 11 channel IEEE802.11n/ac(40M): 5470MHz ~5725 MHz/ 5 channel IEEE802.11ac/ax(80M): 5470MHz ~5725 MHz/ 2 channel IEEE 802.11a/n/ac(20M): 5725MHz ~5850MHz/ 5 channel IEEE 802.11n/ac(40M): 5725MHz ~5850MHz/ 2 channel IEEE 802.11ac/ax(80M): 5725MHz ~5850MHz/ 1 channel
Max. RF output power:	WiFi (5G): 17.838dBm
Type of Modulation:	WiFi (5G):, OFDM/OFDMA, DSSS, OFDM, CCK
Antenna installation:	WiFi (5G): 802.11a: External Antenna 1: 2.0dBi 802.11a: External Antenna 2: 2.0dBi
Antenna Gain:	The 5G WIFI , 802.11n20, 802.11n40, 802.11n80, 802.11ax80 can MIMO model, then the antenna gain as below: Directional gain= $2.0dBi+10 \times log(1+1)dB=5.01dBi$
Ratings:	Input: 3.3V === 1A
wireless router	The restart time for the router and the module is 120 seconds

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4.2 Test Setup Configuration

See test photographs attached in EUT TEST SETUP PHOTOGRAPHS for the actual connections between Product and support equipment.

4.3 Support Equipment

No.	Device Type	Brand	Model	Series No.	Data Cable	FCC ID	Power Cord
1.	Intelligent Wireless Access Point	Technity Solutions Inc.	Intelligent Wireless Access Point	N/A	N/A	2ATAZ-MWI3000W4P	N/A

Notes:

1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.

2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

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For 802.	11a/n/ac(20M) Operation	in the 5250MHz ~5350	MHz band
Channel	Frequency	Channel	Frequency
52	5260MHz	60	5300MHz
56	5280MHz	64	5320MHz
For 802.	11a/n/ac(20M) Operation	in the 5470MHz ~5725	MHz band
Channel	Frequency	Channel	Frequency
100	5500MHz	124	5620 MHz
104	5520MHz	128	5640 MHz
108	5540MHz	132	5660 MHz
112	5560MHz	136	5680MHz
116	5580MHz	140	5700MHz
120	5600 MHz		

For 802.11n/a	ac(40M) Operation	in the	5250MHz ~5350 N	/IHz band
Channel	Frequency	/	Channel	Frequency
54	5270MHz		62	5310MHz
For 802.11n/a	ac(40M) Operation	in the	5470MHz ~5725 M	/IHz band
Channel	Frequency	1	Channel	Frequency
102	5510MHz		126	5630MHz
110	5550MHz		134	5670MHz
118	5590MHz			

For 802.11ac/ax	(80M) Operation in th	e 5250MHz ~5350	MHz band
Channel	Frequency	Channel	Frequency
58	5290MHz	NA	NA
For 802.11ac/ax	(80M) Operation in th	e 5470MHz ~5725	MHz band
Channel	Frequency	Channel	Frequency
106	5530MHz	122	5610 MHz

4.5 Test Mode

All test mode(s) and condition(s) mentioned were considered and evaluated respectively by performing full tests, the worst data were recorded and reported.

000 11 - /= /= - (20 M)		Channel 52	Channel 56	Channel 64
802.11a/n/ac(20M)	5250MHz ~5350 MHz	5260MHz	5280MHz	5320MHz
802.11n/ac(40M)	5250MHz - 5250 MHz	Channel54	N/A	Channel62
	5250MHz ~5350 MHz	5270MHz	N/A	5310MHz
802.11ac/ax(80M)	5250MHz ~5350 MHz	N/A	Channel 58	N/A
		N/A	5290MHz	N/A
802 11 a/p/ac(20M)	5470MHz ~5725 MHz -	Channel 100	Channel116	Channel140
802.11a/n/ac(20M)		5500MHz	5580MHz	5700MHz
802 11n/co(40M)		Channel 102	Channel118	Channel 134
802.11n/ac(40M)	5470MHz ~5725 MHz	5510MHz	5590MHz	5670MHz
902 11cc/cx(90M)	5470MHz ~5725 MHz	Channel 106	N/A	Channel 122
802.11ac/ax(80M)	047 UNI⊓Z ~0720 NI⊓Z	5530MHz	N/A	5610MHz



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4.6 Test Environment

Humidity(%):	54
Atmospheric Pressure(kPa):	101
Normal Voltage(DC):NV	5
Normal Temperature(°C):NT	23
Low Temperature(℃):LT	0
High Temperature(℃):HT	40







5. TEST FACILITY AND TEST INSTRUMENT USED

5.1 Test Facility

All measurement facilities used to collect the measurement data are located at 1&2F., Building A, No. 26, Xinhe Road, Xinqiao, Xinqiao Street, Bao'an District, Shenzhen, Guangdong, China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4 and CISPR 16-1-1 other equivalent standards.

5.2 Test Instrument Used

	Radiation emission				Firmware		
Item	Equipment	Manufacturer	Type No.	Serial No.	Version	Last calibration	Calibrated until
1	Spectrum Analyzer (9kHz-26.5GHz)	KEYSIGHT	9020A	MY55370835	A.17.05	Nov. 02, 2023	Nov. 01, 2024
2	Spectrum Analyzer (10kHz-39.9GHz)	R&S	FSV40-N	100363	1.71 SP2	Nov. 02, 2023	Nov. 01, 2024
3	EMI Test Receiver (9kHz-7GHz)	R&S	ESCI7	100969	4.32	Nov. 02, 2023	Nov. 01, 2024
4	Bilog Antenna (30MHz-1500MHz)	Schwarzbeck	VULB9168	N/A	N/A	Nov. 13, 2023	Nov. 12, 2024
5	Horn Antenna (1GHz-18GHz)	Agilent	AH-118	071145	N/A	Nov. 13, 2023	Nov. 12, 2024
6	Horn Antenna (15GHz-40GHz)	A.H.System	SAS-574	588	N/A	Nov. 13, 2023	Nov. 12, 2024
7	Loop Antenna	TESEQ	HLA6121	58357	N/A	Nov. 16, 2023	Nov. 15, 2024
8	Amplifier (30-1000MHz)	EM Electronics	EM330 Amplifier	60747	N/A	Nov. 02, 2023	Nov. 01, 2024
9	Amplifier (1GHz-26.5GHz)	HuiPu	8449B	3008A00315	N/A	Nov. 02, 2023	Nov. 01, 2024
10	Amplifier (500MHz-40GHz)	QuanJuDa	DLE-161	097	N/A	Nov. 02, 2023	Nov. 01, 2024
11	Test Cable	N/A	R-01	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
12	Test Cable	N/A	R-02	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
13	Test Cable	N/A	R-03	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
14	Test Cable	N/A	RF-01	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
15	Test Cable	N/A	RF-02	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
16	Test Cable	N/A	RF-03	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024
17	ESG Signal Generator	Agilent	E4421B	N/A	B.03.84	Nov. 02, 2023	Nov. 01, 2024
18	Signal Generator	Agilent	N5182A	N/A	A.01.87	Nov. 02, 2023	Nov. 01, 2024
19	Magnetic Field Probe Tester	Narda	ELT-400	0-0344	N/A	Nov. 16, 2023	Nov. 15, 2024
20	Wideband Radio Communication Test	R&S	CMW500	106504	V 3.7.22	Nov. 02, 2023	Nov. 01, 2024
21	MWRF Power	MW	MW100-RF	N/A	N/A	Nov. 02, 2023	Nov. 01, 2024

Radiation emissions& Radio Test equipment

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F					Proje	ct No.: ZKT-23102 Page	48076E-4 e 12 of 24
	Meter Test system		СВ				
22	Power Meter	KEYSIGHT	N1912A P	N/A	A.05.00	Nov. 02, 2023	Nov. 01, 2024
23	D.C. Power Supply	LongWei	TPR-6405D	N/A	N/A	\	\
24	EMC Software	Frad	EZ-EMC	Ver.EMC-CO N 3A1.1	N/A		١
25	RF Software	MW	MTS8310	V2.0.0.0	N/A		١
26	Turntable	MF	MF-7802BS	N/A	N/A	\	\
27	Antenna tower	MF	MF-7802BS	N/A	N/A	\	/

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6. TECHNICAL REQUIREMENTS FOR DFS

- 6.1 Applicability of DFS Requirements
- 6.1.1 Applicability of DFS Requirements Prior to use of a Channel

		Operational Mode	•
Requirement	Master	Client Without Radar Detection	Client With Radar Detection
Non-Occupancy Period	Yes	Not required	Yes
DFS Detection Threshold	Yes	Not required	Yes
Channel Availability Check Time	Yes	Not required	Not required
U-NII Detection Bandwidth	Yes	Not required	Yes

6.1.2 Applicability of DFS Requirements during Normal Operation

	Operational Mode			
Requirement	Master or Client With Radar Detection	Client Without Radar Detection		
DFS Detection Threshold	Yes	Not required		
Channel Closing Transmission Time	Yes	Yes		
Channel Move Time	Yes	Yes		
U-NII Detection Bandwidth	Yes	Not required		

Additional requirements for	Operational Mode			
devices with multiple bandwidth modes	Master or Client With Radar Detection	Client Without Radar Detection		
U-NII Detection Bandwidth and Statistical Performance Check	All BW modes must be tested	Not required		
Channel Move Time and Channel Closing Transmission Time	Test using widest BW mode available	Test using the widest BW mode available for the link		
All other tests	Any single BW mode	Not required		

Note: Frequencies selected for statistical performance check (Section 7.8.4) should include several frequencies within the radar detection bandwidth and frequencies near the edge of the radar detection bandwidth. For 802.11 devices it is suggested to select frequencies in each of the bonded 20 MHz channels and the channel center frequency.

6.2 DFS Detection Thresholds and Response Requirement

Below table provides the DFS Detection Thresholds for Master Devices as well as Client Devices incorporating In-Service Monitoring.

DFS Detection Thresholds for Master Devices and Client Devices With Radar Detection.

Maximum Transmit Power	Value (See Notes 1, 2 and 3)	
EIRP ≥ 200 milliwatt	-64 dBm	
EIRP < 200 milliwatt and	-62 dBm	
power spectral density < 10 dBm / MHz		
EIRP < 200 milliwatt and that do not meet	-64 dBm	
the power spectral density requirement		

Note 1: This is the level at the input of the receiver assuming a 0 dBi receive antenna. Note 2: Throughout these test procedures an additional 1 dB has been added to the amplitude of the test transmission waveforms to account for variations in measurement equipment. This will ensure that the test

signal is at or above the detection threshold level to trigger a DFS response. Note3: EIRP is based on the highest antenna gain. For MIMO devices refer to KDB Publication 662911 D01.

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Parameter	Value
Non-occupancy period	Minimum 30 minutes.
Channel Availability Check Time	60 seconds.
Channel Move Time	10 seconds. (See Note 1.)
Channel Closing Transmission Time	200 milliseconds + an aggregate of 60 milliseconds over remaining 10 second period. (See Notes 1 and 2.)
U-NII Detection Bandwidth	Minimum 100% of the U- NII 99% transmission power bandwidth. (See Note 3.)

Note 1: Channel Move Time and the Channel Closing Transmission Time should be performed with Radar

Type 0. The measurement timing begins at the end of the Radar Type 0 burst.

Note 2: The Channel Closing Transmission Time is comprised of 200 milliseconds starting at the beginning of the Channel Move Time plus any additional intermittent control signals required to facilitate a Channel move (an aggregate of 60 milliseconds) during the remainder of the 10 second period. The aggregate duration of control signals will not count quiet periods in between transmissions. Note 3: During the U-NII Detection Bandwidth detection test, radar type 0 should be used. For each frequency step the minimum percentage of detection is 90 percent. Measurements are performed with no data traffic.

6.3 Radar Test Waveforms

This section provides the parameters for required test waveforms, minimum percentage of successful detections, and the minimum number of trials that must be used for determining DFS conformance. Step intervals of 0.1 microsecond for Pulse Width, 1 microsecond for PRI, 1 MHz for chirp width and 1 for the number of pulses will be utilized for the random determination of specific test waveforms.

Radar Type	Pulse Width (µsec)	PRI (µsec)	Number of Pulses	Minimum Percentage of Successful Detection	Minimum Number of Trials
0	1	1428	18	See Note1	See Note1
		Test A: 15 unique PRI values randomly selected from the list of 23 PRI values in Table 5a Test B: 15 unique PRI values randomly selected within the range of 518-3066 µsec, with a minimum increment of 1 µsec, excluding PRI values selected in Test A	Roundup $ \begin{cases} \left(\frac{1}{360}\right) \\ \left(\frac{19 \cdot 10^6}{\text{PRI}_{\mu \text{sec}}}\right) \end{cases} $	60%	30

6.3.1 Short Pulse Radar Test Waveforms

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31						
	2	1-5	150-230	23-29	60%	30
	3	6-10	200-500	16-18	60%	30
	4	1-20	200-500	12-16	60%	30
	Aggregate (Rada	r Types 1-4)			80%	120

Note 1: Short Pulse Radar Type 0 should be used for the detection bandwidth test, channel move time, and channel closing time tests.

A minimum of 30 unique waveforms are required for each of the Short Pulse Radar Types 2 through 4. If more than 30 waveforms are used for Short Pulse Radar Types 2 through 4, then each additional waveform must also be unique and not repeated from the previous waveforms. If more than 30 waveforms are used for Short Pulse Radar Type 1, then each additional waveform is generated with Test B and must also be unique and not repeated from the previous in Tests A or B.

Pulse Repetition Frequency Number	Pulse Repetition Frequency (Pulses Per Second)	Pulse Repetition Interval (Microseconds)
1	1930.5	518
2	1858.7	538
3	1792.1	558
4	1730.1	578
5	1672.2	598
6	1618.1	618
7	1567.4	638
8	1519.8	658
9	1474.9	678
10	1432.7	698
11	1392.8	718
12	1355	738
13	1319.3	758
14	1285.3	778
15	1253.1	798
16	1222.5	818
17	1193.3	838
18	1165.6	858
19	1139	878
20	1113.6	898
21	1089.3	918
22	1066.1	938
23	326.2	3066







6.3.2 Long Pulse Radar Test Waveform

Radar Type	Pulse Width (µsec)	Chirp Width (MHz)	PRI (µsec)	Number of Pulses per Burst	Number of Bursts	Minimum Percentage of Successful Detection	Minimum Number of Trials
5	50-100	5-20	1000-2000	1-3	8-20	80%	30

The parameters for this waveform are randomly chosen. Thirty unique waveforms are required for the Long Pulse Radar Type waveforms. If more than 30 waveforms are used for the Long Pulse Radar Type waveforms, then each additional waveform must also be unique and not repeated from the previous waveforms.

Each waveform is defined as follows:

1) The transmission period for the Long Pulse Radar test signal is 12 seconds.

2) There are a total of 8 to 20 Bursts in the 12 second period, with the number of Bursts being randomly chosen. This number is Burst Count.

3) Each Burst consists of 1 to 3 pulses, with the number of pulses being randomly chosen. Each Burst within the 12 second sequence may have a different number of pulses.

4) The pulse width is between 50 and 100 microseconds, with the pulse width being randomly chosen. Each pulse within a Burst will have the same pulse width. Pulses in different Bursts may have different pulse widths. 5) Each pulse has a linear frequency modulated chirp between 5 and 20 MHz, with the chirp width being randomly chosen. Each pulse within a transmission period will have the same chirp width. The chirp is centered on the pulse. For example, with a radar frequency of 5300 MHz and a 20 MHz chirped signal, the chirp starts at 5290 MHz and ends at 5310 MHz.

6) If more than one pulse is present in a Burst, the time between the pulses will be between 1000 and 2000 microseconds, with the time being randomly chosen. If three pulses are present in a Burst, the random time interval between the first and second pulses is chosen independently of the random time interval between the second and third pulses.

7) The 12 second transmission period is divided into even intervals. The number of intervals is equal to Burst Count. Each interval is of length (12,000,000 / Burst Count) microseconds. Each interval contains one Burst. The start time for the Burst, relative to the beginning of the interval, is between 1 and [(12,000,000 / Burst Count) – (Total Burst Length) + (One Random PRI Interval)] microseconds, with the start time being randomly chosen. The step interval for the start time is 1 microsecond. The start time for each Burst is chosen randomly.

A representative example of a Long Pulse Radar Type waveform:

1) The total test waveform length is 12 seconds.

- 2) Eight (8) Bursts are randomly generated for the Burst Count.
- 3) Burst 1 has 2 randomly generated pulses.

4) The pulse width (for both pulses) is randomly selected to be 75 microseconds.

5) The PRI is randomly selected to be at 1213 microseconds.

6) Bursts 2 through 8 are generated using steps 3 - 5.

7) Each Burst is contained in even intervals of 1,500,000 microseconds. The starting location for Pulse 1, Burst 1 is randomly generated (1 to 1.500.000 minus the total Burst 1 length + 1 random PRI interval) at the 325.001 microsecond step. Bursts 2 through 8 randomly fall in successive 1,500,000 microsecond intervals (i.e. Burst 2 falls in the 1,500,001 - 3,000,000 microsecond range).



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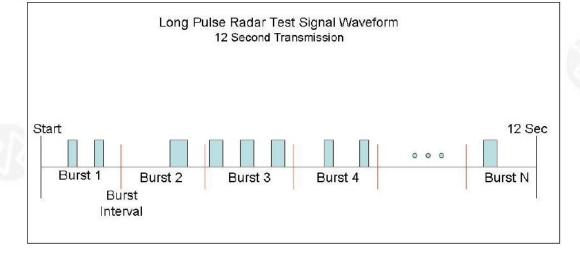








Graphical representation of the Long Pulse Radar Test Waveform.



6.3.3 Frequency Hopping Radar Test Waveform

Radar Type	Pulse Width (μsec)	PRI (µsec)	Pulses per Hop	Hopping Rate (kHz)	Hopping Sequence Length (msec)	Minimum Percentage of Successful Detection	Minimum Number of Trials
6	1	333	9	0.333	300	70%	30

For the Frequency Hopping Radar Type, the same *Burst* parameters are used for each waveform. The hopping sequence is different for each waveform and a 100-length segment is selected from the hopping sequence defined by the following algorithm:

The first frequency in a hopping sequence is selected randomly from the group of 475 integer frequencies from 5250 – 5724 MHz. Next, the frequency that was just chosen is removed from the group and a frequency is randomly selected from the remaining 474 frequencies in the group. This process continues until all 475 frequencies are chosen for the set. For selection of a random frequency, the frequencies remaining within the group are always treated as equally likely

Radar Waveform Calibration

The following equipment setup was used to calibrate the conducted radar waveform. A spectrum analyzer was used to establish the test signal level for each radar type. During this process there were replace 500hm terminal from master and client device and no transmissions by either the master or client device. The spectrum analyzer was switched to the zero span (time domain) at the frequency of the radar waveform generator. Peak detection was utilized. The spectrum analyzer resolution bandwidth (RBW) and video bandwidth (VBW) were set to 3MHz and 3 MHz.

The signal generator amplitude was set so that the power level measured at the spectrum analyzer was -61dBm due to the interference threshold level is not required

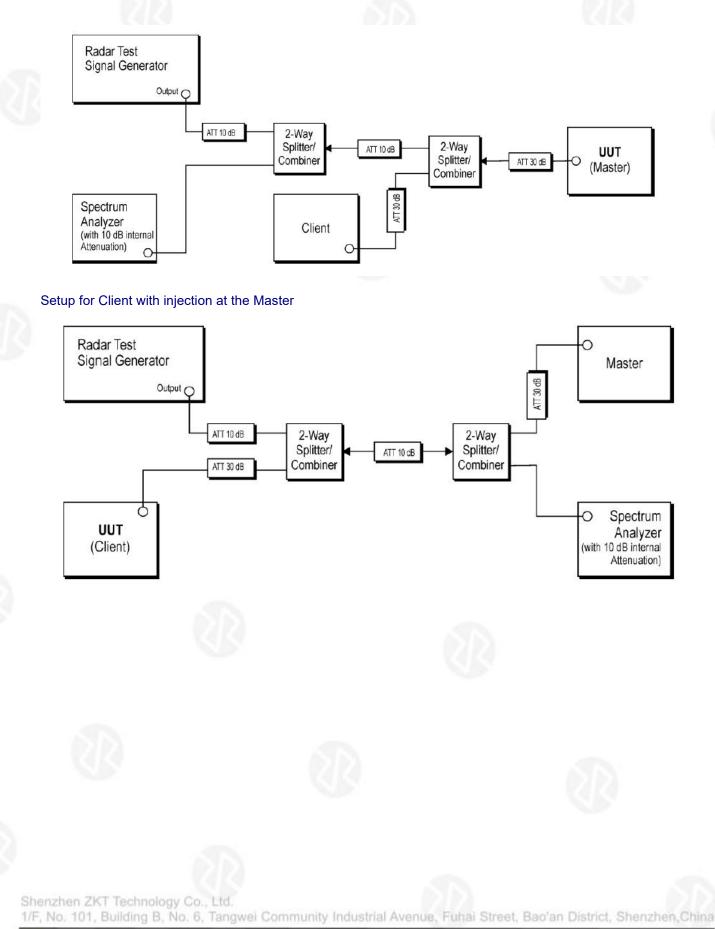
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6.3.4 DFS test setup

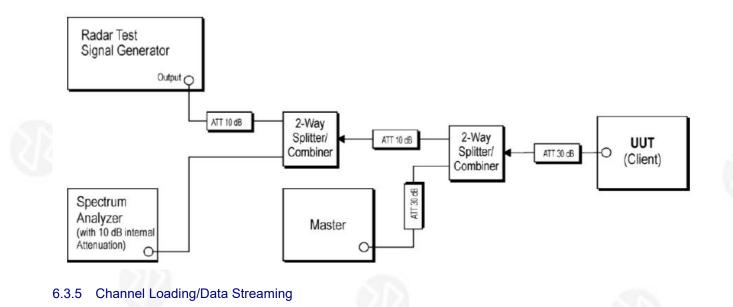
Setup for Master with injection at the Master



1



Setup for Client with injection at the Client



Timing plots are required with calculations demonstrating a minimum channel loading of approximately 17% or greater.

		Q AC	SENS	EINT	ALIGN AUTO		
arker 2	Δ 16.6599	F		rig: Free Run Atten: 0 dB	Avg Typ	e: Log-Pwr	TRACE 123 TYPE WAAA DET PNN
) dB/div	Ref -20.0	0 dBm					ΔMkr2 16.66 2.80
og 0.0							2∆3
0.0		X!* //					
0.0							
0.0 0.0 <mark>10000000000000000000000000000000000</mark>	alifa Hidra	udiaanina y la ka y tahahanaha	na an at at a threat to be been	enillein vormlasteile	ka lithainteachtanth an d	hing han talka ta kar di	herenden is a herenden and
0.0							
100							
100							
enter 5.3	300000000 3 MHz	GHz	#VBW 8	3.0 MHz		Swee	Span 0 p 25.07 ms (8001
enter 5.3 es BW 8	B MHZ	×	Y	FUNCTION	FUNCTION WIDTH		Span 0 25.07 ms (8001 UNCTION VALUE
enter 5.3 es BW 8 KR MODE TR 1 Δ2 1	RC SCL	× -15.42 ms	γ (Δ) 0.73 dl	FUNCTION	. FUNCTION WIDTH		p 25.07 ms (8001
enter 5. es BW 8 R MODE TF 1 A2 1 2 A3 1 3 F 1	3 MHz RC SCL t (Δ) t (Δ)	×	γ (Δ) 0.73 dl	FUNCTION	FUNCTION WIDTH		p 25.07 ms (8001
enter 5.: es BW 8 (R MODE TF 1 A2 1 2 A3 1 3 F 1 4 5	3 MHz RC SCL t (Δ) t (Δ)	× -15.42 ms 16.66 ms	γ (Δ) 0.73 dl (Δ) 2.80 dl	FUNCTION	FUNCTION WIDTH		p 25.07 ms (8001
enter 5.: es BW 8 R MODE TF 2 A3 1 3 F 1 4 5 6 5	3 MHz RC SCL t (Δ) t (Δ)	× -15.42 ms 16.66 ms	γ (Δ) 0.73 dl (Δ) 2.80 dl	FUNCTION	FUNCTION WIDTH		p 25.07 ms (8001
enter 5.: es BW 8 R MODE TF 1 A2 1 2 A3 1 3 F 1 4 5 6 6 7 8	3 MHz RC SCL t (Δ) t (Δ)	× -15.42 ms 16.66 ms	γ (Δ) 0.73 dl (Δ) 2.80 dl	FUNCTION	FUNCTION WIDTH		p 25.07 ms (8001
III0 center 5. ces BW 8 III0 III0<	3 MHz RC SCL t (Δ) t (Δ)	× -15.42 ms 16.66 ms	γ (Δ) 0.73 dl (Δ) 2.80 dl	FUNCTION	FUNCTION WIDTH		p 25.07 ms (800
enter 5.: es BW 8 KR MODE TF 1 A2 1 2 A3 1 3 F 1 4 5 5 5 6 7 7 8	3 MHz RC SCL t (Δ) t (Δ)	× -15.42 ms 16.66 ms	γ (Δ) 0.73 dl (Δ) 2.80 dl	FUNCTION	FUNCTION WIDTH		p 25.07 ms (8001

The worst values were recorded only

1





Trace Ref Level

Trace Ref Level

DFS DETECTION THRESHOLD LEVELS 7.

Test result:

Radar type0

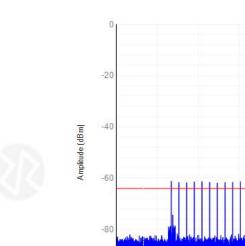
DFS Threshold level: -63 dBm

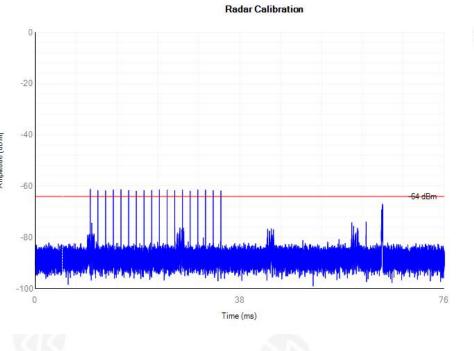
The Interference Radar Detection Threshold Level is (-64dBm) +(0)[dBi]+ 1 dB= -63 dBm. That ad been taken into account the master output power range and antenna gain.

Calibration plots for each of the required radar waveforms

5.3G







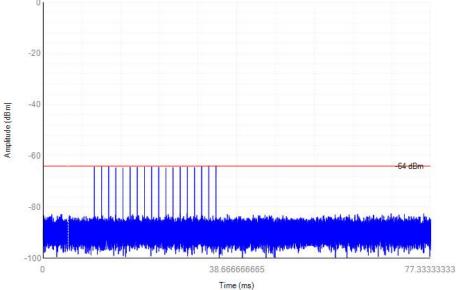


Radar Calibration





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8. CONDUCTED TEST PROCEDURE

1) One frequency will be chosen from the Operating Channels of the UUT within the 5250-5350 MHz or 5470-5725MHz bands.

2) The Client Device (EUT) is set up the above diagram and communications between the Master device and the Client is established.

3) Stream the channel loading test file from the Master Device to the Client Device on the test Channel for the entire period of the test.

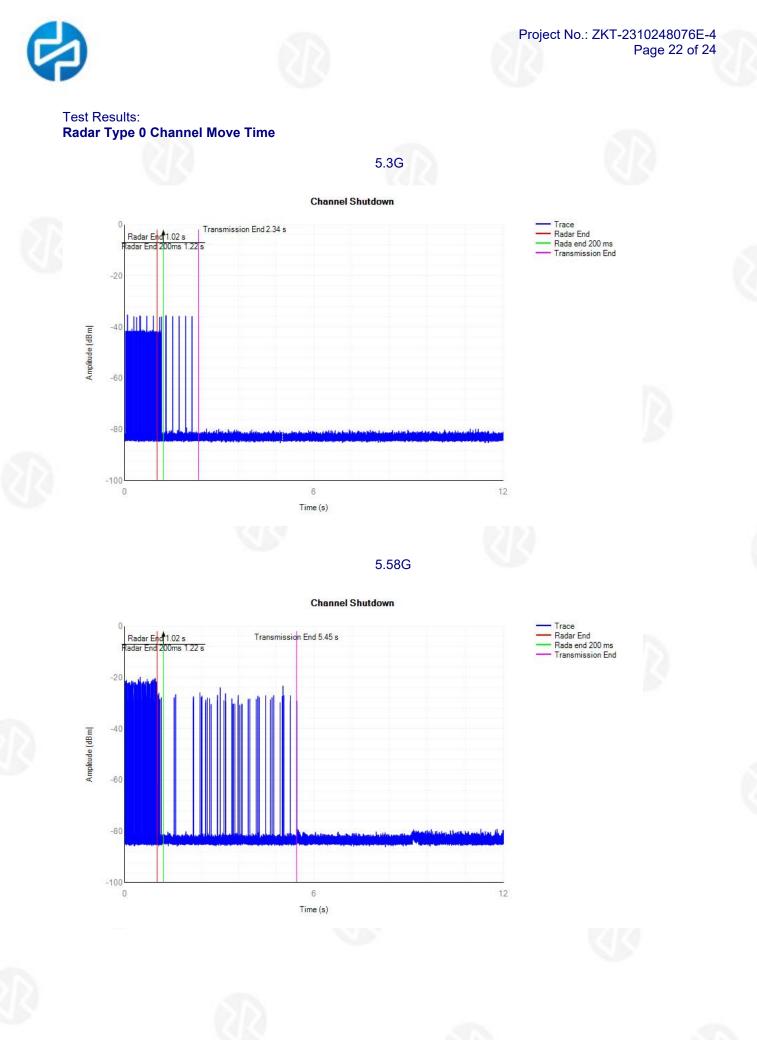
4) An additional 1 dB is added to the radar test signal to ensure it is at or above the DFS Detection Threshold, accounting for equipment variations/errors.

5) Observe the transmissions of the UUT at the end of the Burst on the Operating Channel for duration greater than 12 seconds for Radar Type 0 to ensure detection occurs.

6) After the initial radar burst the channel is monitored for 30 minutes to ensure no transmissions or beacons occur. A second monitoring setup is used to verify that the Master and Client have both moved to different channels.

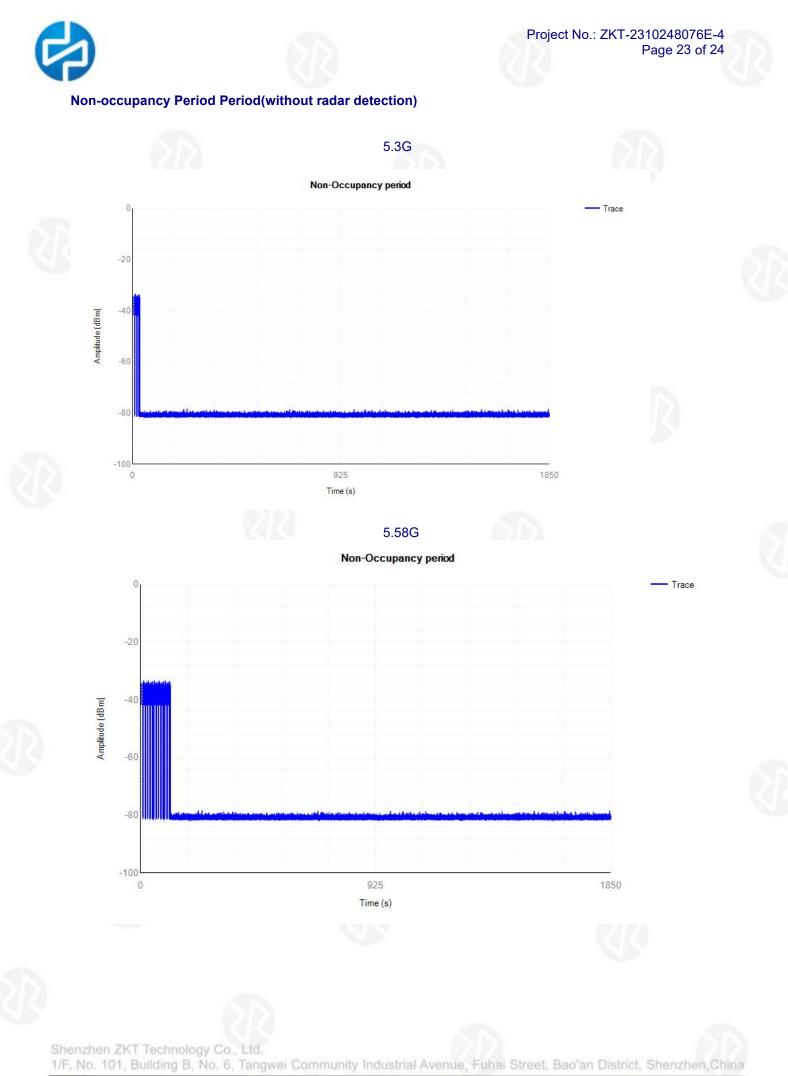


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Test Item	Modulation Mode	Freq. (GHz)	Limit	Results
Channel Move Time	A20	5.3	10s	Pass
Channel Move Time	A20	5.58	10s	Pass
Non-Occupancy Period	A20	5.3	30 minutes	Pass
Non-Occupancy Period	A20	5.58	30 minutes	Pass

******** END OF REPORT ******

